

# Sparse logistic regression: model selection, goodness-of-fit and classification

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(based on joint work with Vadim Grinshtein, The Open University of Israel)

# Outline

- ① Model selection in sparse logistic regression
  - ▶ theoretical results: risk bounds, adaptive rate-optimal estimators
  - ▶ computational aspects
- ② Classification by sparse logistic regression
- ③ Possible extensions

# Sparse logistic regression

- $Y_i \sim B(1, p_i), \quad i = 1, \dots, n$
- $\text{logit}(p_i) = \ln \frac{p_i}{1-p_i} = \boldsymbol{\beta}^t \mathbf{x}_i, \quad \mathbf{x}_i \in \mathbb{R}^d, \quad \text{logit}(\mathbf{p}) = X_{n \times d} \boldsymbol{\beta}$

$\text{rank}(X) = r \leq \min(n, d)$ , any  $r$  columns of  $X$  are linearly independent

- **Key sparsity assumption:** only some subset of predictors is really “relevant”:  $\|\boldsymbol{\beta}\|_0 \leq d_0$

**Goal:** to identify this “relevant subset” (the “best” model)

## Model selection by penalized MLE

- For a given model  $M \subset \{1, \dots, d\}$ ,

$$\hat{\beta}_M = \arg \max_{\tilde{\beta} \in \mathcal{B}_M} \ell(\tilde{\beta}) = \arg \max_{\tilde{\beta} \in \mathcal{B}_M} \sum_{i=1}^n \left\{ \tilde{\beta}_M^t \mathbf{x}_i Y_i - \ln \left( 1 + \exp(\tilde{\beta}_M)^t \mathbf{x}_i \right) \right\}$$

where  $\mathcal{B}_M = \{\beta \in \mathbb{R}^d : \beta_j = 0 \text{ if } j \notin M\}$ .

$$\hat{p}_{Mi} = \frac{\exp(\hat{\beta}_M^t \mathbf{x}_i)}{1 + \exp(\hat{\beta}_M^t \mathbf{x}_i)}, \quad i = 1, \dots, n$$

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- $\hat{M} = \arg \min_M \left\{ \sum_{i=1}^n \left( \ln \left( 1 + \exp(\hat{\beta}_M^t \mathbf{x}_i) \right) - \hat{\beta}_M^t \mathbf{x}_i Y_i \right) + Pen(|M|) \right\}$

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**Key question:** how to choose a “proper” complexity penalty  $Pen(|M|)$ ?

# Complexity Penalties

- linear-type penalties  $\text{Pen}(|M|) = \lambda|M|$

$\lambda = 1$       AIC (Akaike, '73)

$\lambda = \ln(n)/2$     BIC (Schwarz, '78)

$\lambda = \ln d$       RIC (Foster and George, '94)

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- $k \ln(d/k)$ -type nonlinear penalties  $\text{Pen}(|M|) \sim C|M| \ln(de/|M|)$   
(Birgé and Massart, '01, '07; Bunea *et al.* '07; AG '10 for Gaussian regression; AG '16 for GLM)

$$k \ln(d/k) \sim \ln \binom{d}{k} - \log(\text{number of models of size } k)$$

slight modification for  $k = r$ :  $\text{Pen}(r) = Cr$

## Goodness-of-fit: Kullback-Leibler risk

$$EKL(\mathbf{p}, \hat{\mathbf{p}}_{\hat{M}}) = E \left\{ \sum_{i=1}^n \left( p_i \ln \left( \frac{p_i}{\hat{p}_{\hat{M}_i}} \right) + (1 - p_i) \ln \left( \frac{1 - p_i}{1 - \hat{p}_{\hat{M}_i}} \right) \right) \right\}$$

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### Assumption (A)

There exists  $0 < \delta < 1/2$  such that  $\delta \leq p_i \leq 1 - \delta$  or, equivalently,  
 $|\beta^t \mathbf{x}_i| \leq C_0$ ,  $i = 1, \dots, n$

( $Var(Y_i) = p_i(1 - p_i)$  cannot be infinitely close to zero)

Define  $\mathcal{B}(d_0) = \{\beta \in \mathbb{R}^d : \|\beta\|_0 \leq d_0\}$ .

### Theorem (upper bound, AG '16)

Consider  $\text{Pen}(k) = Ck \ln\left(\frac{de}{k}\right)$ ,  $k = 1, \dots, r - 1$  and  $\text{Pen}(r) = Cr$ , where  $C > \frac{4}{\delta(1-\delta)}$ . Then, under Assumption (A), for some  $C_1 > 0$

$$\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \widehat{\mathbf{p}}_{\widehat{M}}) \leq C_1 \frac{1}{\delta(1-\delta)} \min\left(d_0 \ln\left(\frac{de}{d_0}\right), r\right)$$

### Theorem (minimax lower bound, AG '16)

Under Assumption (A),

$$\inf_{\widetilde{\mathbf{p}}} \sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \widetilde{\mathbf{p}}) \geq \begin{cases} C_2 \delta(1-\delta) \tau[2d_0] d_0 \ln\left(\frac{de}{d_0}\right), & 1 \leq d_0 \leq r/2 \\ C_2 \delta(1-\delta) \tau[d_0] r, & r/2 \leq d_0 \leq r \end{cases}$$

where  $\tau[k]$  is the ratio between the minimal and maximal  $k$ -sparse eigenvalues of  $X$

## Remarks

- All the above results for model selection in logistic regression can be extended to a general GLM (AG '16):

- ▶  $Y_i \sim f_{\theta_i}(y), \quad f_{\theta_i}(y) = \exp \left\{ \frac{y\theta_i - b(\theta_i)}{a} + c(y, a) \right\}$
- ▶  $\theta_i = \beta^t \mathbf{x}_i, \quad \mathbf{x}_i \in \mathbb{R}^d$

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- The results can be extended to model selection under additional **structural constraints** on the set of admissible models (AG '16)

$$Pen(|M|) = C \max(\ln m(|M|), |M|), \text{ where } m(k) = \#\{M : |M| = k\}$$

$$\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \hat{\mathbf{p}}_{\hat{M}}) = O(\max(\ln m(d_0), d_0))$$

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- Under Assumption (A),  $EKL(\mathbf{p}, \hat{\mathbf{p}}) \asymp \|\mathbf{X}\beta - \mathbf{X}\hat{\beta}\|^2 \asymp \|\beta - \hat{\beta}\|^2$  all the results remain true (with different constants) for estimating  $X\beta$  and  $\beta$

## Computational aspects

$$\hat{M} = \arg \min_M \left\{ -\hat{\ell}(M) + Pen(|M|) \right\}$$

combinatorial search over  $2^d$  models (NP problem)

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# Computational aspects

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combinatorial search over  $2^d$  models (NP problem)

- Greedy algorithms (e.g., forward selection) – approximate the global solution by a stepwise sequence of local ones  
(requires strong constraints on  $X$ )
- Convex relaxation methods – replace the original combinatorial problem by some convex surrogate

# Convex relaxation methods

(assume that columns of  $X$  are normalized to have unit norms)

- Lasso (for linear penalties):  $|M| = \|\beta\|_0 \rightarrow \|\beta\|_1$

$$\hat{\beta}_{Lasso} = \arg \min_{\beta} \{-\ell(\beta) + \lambda \|\beta\|_1\}$$

- fixed  $\lambda \propto \sqrt{\ln d}$

Under an additional restricted eigenvalue condition on  $X$

$$\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \hat{\mathbf{p}}_{Lasso}) \leq C \frac{1}{\delta(1-\delta)} d_0 \ln d$$

(van de Geer '08)

- adaptively chosen  $\lambda$  (Lepski-type procedure)

Under somewhat more restrictive conditions on  $X$

$$\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \hat{\mathbf{p}}_{Lasso}) \leq C \frac{1}{\delta(1-\delta)} d_0 \ln(de/d_0)$$

(Bellegue, Lecué and Tsybakov '16 for Gaussian regression; conjecture for logistic regression)

- SLOPE (Bogdan *et al.* '15):  $k \ln(2d/k) \sim \sum_{j=1}^k \ln(2d/j)$

$$\hat{\beta}_{Slope} = \arg \min_{\beta} \left\{ -\ell(\beta) + \sum_{j=1}^p \lambda_j |\beta|_{(j)} \right\}$$

$$\lambda_j \propto \sqrt{\ln(2d/j)}$$

Under an additional weighted restricted eigenvalue condition on  $X$

$$\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \hat{\mathbf{p}}_{Slope}) \leq C \frac{1}{\delta(1-\delta)} d_0 \ln(de/d_0)$$

(Su and Candes '16; Bellec, Lecué and Tsybakov '16 for Gaussian regression; AG '17 for GLM)

# Classification

- $Y|\mathbf{x} \sim B(1, p(\mathbf{x}))$ ,  $\mathbf{x} \in \mathbb{R}^d$
- **Classifier**  $\eta : \mathbb{R}^d \rightarrow \{0, 1\}$
- **Missclassification error**  $R(\eta) = P(Y \neq \eta(\mathbf{x}))$
- **Bayes classifier**  $\eta^*(\mathbf{x}) = I\{p(\mathbf{x}) \geq 1/2\}$

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- Data  $D = ((\mathbf{x}_1, Y_1), \dots, (\mathbf{x}_n, Y_n))$  (fixed or random design)  
(conditional) Missclassification error  $R(\hat{\eta}) = P(Y \neq \hat{\eta}(\mathbf{x})|D)$

$$\text{Missclassification excess risk } \mathcal{E}(\hat{\eta}, \eta^*) = ER(\hat{\eta}) - R(\eta^*)$$

## Two main approaches

### ① Empirical Risk Minimization (ERM)

$$\hat{\eta} = \arg \min_{\eta \in \mathcal{C}} \hat{R}(\eta) = \arg \min_{\eta \in \mathcal{C}} \frac{1}{n} \sum_{i=1}^n I(Y_i \neq \eta(\mathbf{x}_i))$$

- ▶ well-developed theory  
(Devroye, Györfi and Lugosi '96; Vapnik '00; see also Boucheron, Bousquet and Lugosi '05 for review)
- ▶ computationally infeasible, various convex surrogates (e.g., SVM)

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## ② Plug-in Classifier

- ▶ estimate  $p(\mathbf{x})$  from the data  
(e.g, (parametric) logistic regression:  $\ln \frac{p(\mathbf{x})}{1-p(\mathbf{x})} = \boldsymbol{\beta}^t \mathbf{x}$  or nonparametric – Koltchinskii and Beznosova 05', Audibert and Tsybakov 07')
- ▶ plug-in  $\hat{\eta}(\mathbf{x}) = I(\hat{p}(\mathbf{x}) \geq 1/2)$

## Logistic regression classifier

- ①  $\ln \frac{p(\mathbf{x})}{1-p(\mathbf{x})} = \boldsymbol{\beta}^t \mathbf{x}$
- ② estimate  $\boldsymbol{\beta}$  by MLE
- ③ plug-in  $\hat{\eta}(\mathbf{x}) = I(\hat{p}(\mathbf{x}) \geq 1/2) = I(\hat{\boldsymbol{\beta}}^t \mathbf{x} \geq 0)$  – linear classifier

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## Sparse logistic regression classifier

- ① select the model  $\hat{M}$  (e.g., by penalized MLE – see above)
- ② plug-in  $\hat{\eta}_{\hat{M}}(\mathbf{x}) = I(\hat{\boldsymbol{\beta}}_{\hat{M}}^t \mathbf{x} \geq 0)$

# Sparse logistic regression classifier

$$Pen(|M|) = C|M| \ln \frac{de}{|M|}, \quad |M| \leq r - 1; \quad Pen(r) = C r$$

$\mathcal{C}(d_0) = \{\eta(\mathbf{x}) = I\{\boldsymbol{\beta}^t \mathbf{x} \geq 0\} : \boldsymbol{\beta} \in \mathbb{R}^d, \|\boldsymbol{\beta}\|_0 \leq d_0\}$  – the set of  $d_0$ -sparse linear classifiers

Lemma (thanks to Noga Alon)

Vapnik-Chervonenkis dimension  $VC(\mathcal{C}(d_0)) \sim d_0 \ln \left( \frac{de}{d_0} \right)$  :

$$d_0 \log_2 \left( \frac{2d}{d_0} \right) \leq VC(\mathcal{C}(d_0)) \leq 2d_0 \log_2 \left( \frac{de}{d_0} \right)$$

Hence,  $Pen(|M|) \propto VC(\mathcal{C}(|M|))$

Fixed design; average misclassification error  $R_X(\eta) = \frac{1}{n} \sum_{i=1}^n P(Y_i \neq \eta(\mathbf{x}_i))$

$$\mathcal{E}_X(\hat{\eta}, \eta^*) = ER_X(\hat{\eta}) - R_X(\eta^*)$$

- Assumption (A):  $\delta \leq p_i \leq 1 - \delta, \quad i = 1, \dots, n$

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- $\sup_{\beta \in \mathcal{B}(d_0)} EKL(\mathbf{p}, \widehat{\mathbf{p}}_{\widehat{M}}) \leq O\left(\min\left(d_0 \ln \frac{de}{d_0}, r\right)\right)$

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(see above)

- $\mathcal{E}_X(\hat{\eta}_{\hat{M}}, \eta^*) \leq \sqrt{\frac{2}{n} EKL(\mathbf{p}, \hat{\mathbf{p}}_{\hat{M}})}$

(Zhang '04; Bartlett, Jordan and McAuliffe '06)

# Excess risk bounds

## Theorem (upper bound)

Under Assumption (A), for the  $k \ln(d/k)$ -type complexity penalty,

$$\sup_{\eta \in \mathcal{C}(d_0)} \mathcal{E}_X(\hat{\eta}_{\widehat{M}}, \eta^*) \leq C_1 \sqrt{\frac{1}{\delta(1-\delta)} \frac{\min \left( d_0 \ln \frac{de}{d_0}, r \right)}{n}}$$

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## Theorem (minimax lower bound)

Consider a sparse agnostic ( $R(\eta^* > 0)$ ) logistic regression model with  $2 \leq d_0 \ln \frac{2d}{d_0} \leq n$ . There exists a design matrix  $X_0$  such that

$$\inf_{\tilde{\eta}} \sup_{\eta^* \in \mathcal{C}(d_0)} \mathcal{E}_{X_0}(\tilde{\eta}, \eta^*) \geq C_2 \sqrt{\frac{d_0 \ln \frac{de}{d_0}}{n}}$$

or (see Lemma)  $\inf_{\tilde{\eta}} \sup_{\eta^* \in \mathcal{C}(d_0)} \mathcal{E}_{X_0}(\tilde{\eta}, \eta^*) \geq C_2 \sqrt{\frac{VC(\mathcal{C}(d_0))}{n}}$

## Extensions. Tighter risk bounds under low-noise condition

Assume an additional **low-noise condition** ( $p_i$  are separated from 1/2):

$$h \leq |p_i - 1/2| \leq \Delta, \quad i = 1, \dots, n$$

(Massart and Nédélec '06)

$$\mathcal{E}_X(\hat{\eta}_{\hat{M}}, \eta^*) = O \left( \min \left\{ \sqrt{\frac{\min(d_0 \ln \frac{de}{d_0}, r)}{n}}, \frac{\min(d_0 \ln \frac{de}{d_0}, r)}{nh} \right\} \right)$$

- the excess risk is reduced for  $h > \sqrt{\frac{\min(d_0 \ln \frac{de}{d_0}, r)}{n}}$
- $\hat{\eta}_{\hat{M}}$  is rate-optimal classifier (in terms of “the worst case design”)

## Random design (in progress)

$$(\mathbf{X}, Y) \sim \mathcal{F} : Y|\mathbf{x} \sim B(1, p(\mathbf{x})), \ln \frac{p(\mathbf{x})}{1 - p(\mathbf{x})} = \boldsymbol{\beta}^t \mathbf{x}, \|\boldsymbol{\beta}\|_0 \leq d_0; \mathbf{X} \sim f(\mathbf{x})$$

- minimax lower bound (Devroye, Györfi and Lugosi, '96 + Lemma)

$$\inf_{\tilde{\eta}} \sup_{\eta^* \in \mathcal{C}(d_0), h} \mathcal{E}(\tilde{\eta}, \eta^*) \geq \sqrt{\frac{V(\mathcal{C}(d_0))}{n}} \sim C \sqrt{\frac{d_0 \ln \frac{de}{d_0}}{n}}$$

- Assume

$$\delta \leq p(\mathbf{x}) \leq 1 - \delta, \quad 0 < \delta < 1/2; \quad f(\mathbf{x}) \geq \gamma > 0, \quad \mathbf{x} \in \text{supp } f(\mathbf{x})$$

- upper bound for  $k \ln(d/k)$ -type complexity penalty

$$\sup_{\eta^* \in \mathcal{C}(d_0)} \mathcal{E}(\hat{\eta}_{\widehat{M}}, \eta^*) = O \left( \sqrt{\frac{d_0 \ln \frac{de}{d_0}}{n}} \right)$$

- The rates can be improved under additional low-noise conditions

## Multiclass classification by multinomial logistic regression (in progress)

$$\mathbf{Y} \sim \text{Multinom}(p_1(\mathbf{x}), \dots, p_L(\mathbf{x})), \quad \mathbf{Y} \in \{0, 1\}^L, \quad \mathbf{x} \in \mathbb{R}^d$$

$$\sum_{j=1}^L Y_j = 1, \quad \sum_{j=1}^L p_j(\mathbf{x}) = 1$$

$$\theta_j = \ln \frac{p_j(\mathbf{x})}{p_L(\mathbf{x})} = \boldsymbol{\beta}_j^t \mathbf{x}, \quad p_j(\mathbf{x}) = \frac{\exp(\boldsymbol{\beta}_j^t \mathbf{x})}{\sum_{k=1}^L \exp(\boldsymbol{\beta}_k^t \mathbf{x})}, \quad \boldsymbol{\beta}_L = \mathbf{0}, \quad j = 1, \dots, L$$

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- Classifier  $\eta : \mathbb{R}^d \rightarrow \{1, \dots, L\}$
- Bayes classifier  $\eta^*(\mathbf{x}) = \arg \max_{1 \leq j \leq L} p_j(\mathbf{x})$

# Sparse multinomial logistic regression

$$\mathbf{Y}_i \sim \text{Multinom}(p_1(\mathbf{x}_i), \dots, p_L(\mathbf{x}_i)), \quad i = 1, \dots, n$$

$$\Theta_{n \times (L-1)} = X_{n \times d} B_{d \times (L-1)}$$

- For a given model  $M \subset \{1, \dots, d\}$ ,  $|M| = \#\{\text{non-zero rows}(B)\}$
- 

$$\widehat{M} = \arg \min_M \left\{ -\widehat{\ell}(M) + C(L-1)|M| \ln \frac{de}{|M|} \right\}$$

- Assumption (A'):  $0 < \delta \leq p_{(1)}(\mathbf{x}) \leq \dots \leq p_{(L)}(\mathbf{x}) \leq 1 - \delta$
- Under Assumption (A')

$$\sup_{B \in \mathcal{B}(d_0)} EKL(P, \widehat{P}_{\widehat{M}}) \leq C_1 \frac{L-1}{\delta} \min \left( d_0 \ln \left( \frac{de}{d_0} \right), r \right),$$

where  $\mathcal{B}_{d_0} = \{B \in \mathbb{R}^{d \times (L-1)} : \#\{\text{non-zero rows}(B)\} \leq d_0\}$

# Sparse multinomial logistic classifier

$$\hat{\eta}_{\hat{M}}(\mathbf{x}) = \arg \max_{1 \leq j \leq L} \hat{p}_{\hat{M}j}(\mathbf{x}) = \arg \max_{1 \leq j \leq L} \hat{\beta}_{\hat{M}j}^t \mathbf{x}$$

Under Assumption (A')

$$\sup_{\eta \in \mathcal{C}(d_0)} \mathcal{E}_X(\hat{\eta}_{\hat{M}}, \eta^*) = O \left( \sqrt{\frac{L-1}{\delta} \frac{\min(d_0 \ln \frac{de}{d_0}, r)}{n}} \right)$$

Thank You!